



迈普电源

MPVA12N65

Power MOSFET

SWITCHING REGULATOR APPLICATIONS

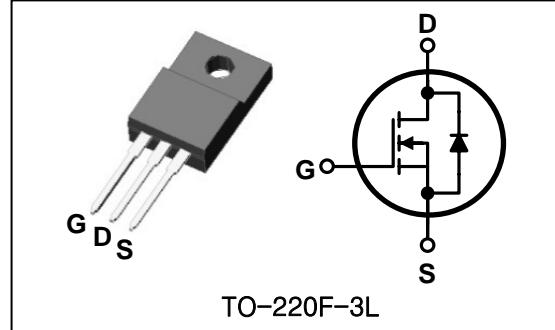
Features

- High Voltage: $BV_{DSS}=650V$ (Min.)
- Low C_{rss} : $C_{rss}=18pF$ (Typ.)
- Low gate charge : $Q_g=42nC$ (Typ.)
- Low $R_{DS(on)}$: $R_{DS(on)}=0.65\Omega$ (Max.)

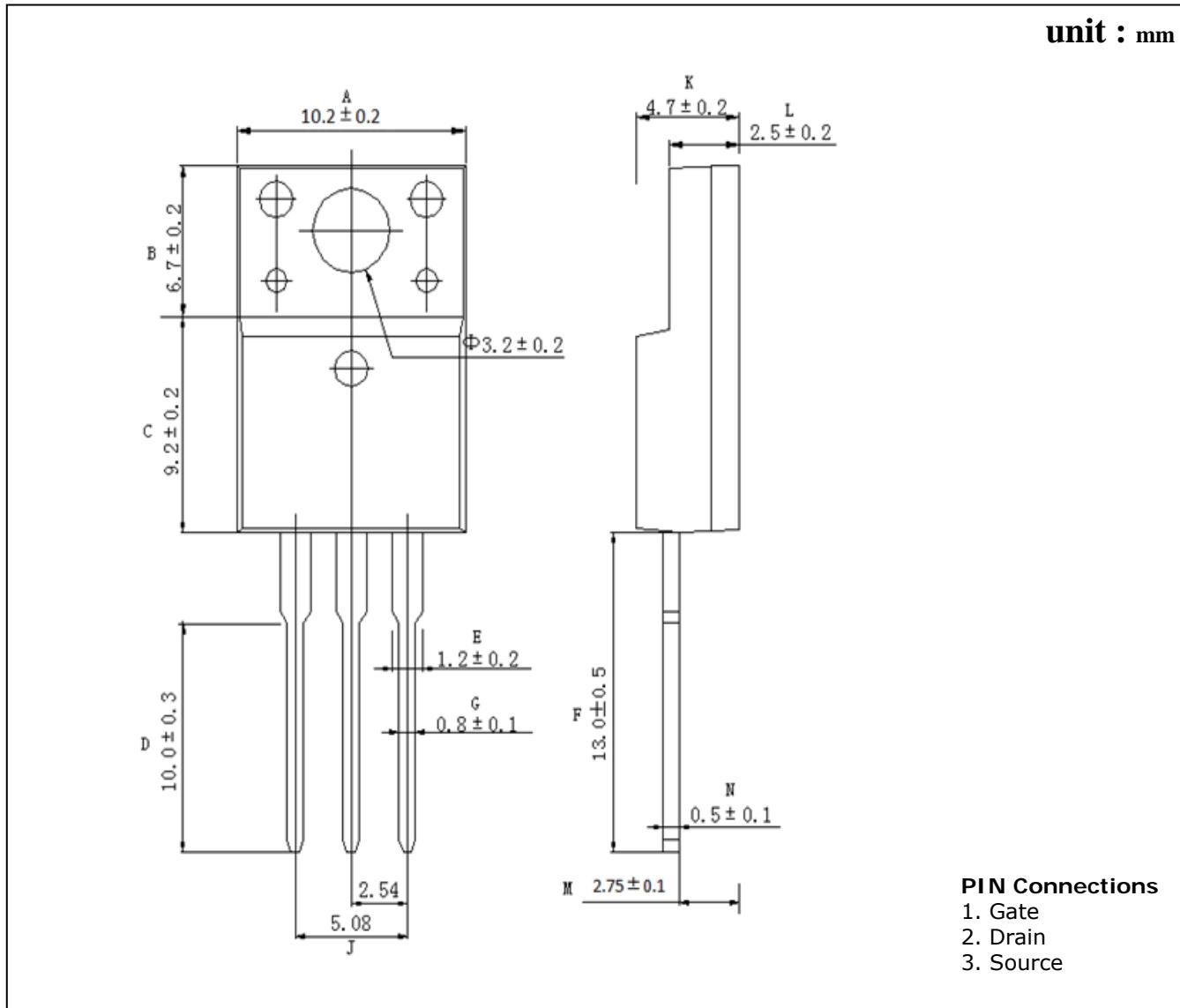
Ordering Information

Type No.	Marking	Package Code
MPVA12N65	MPVA12N65	TO-220F-3L

PIN Connection



Outline Dimensions





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MPVA12N65

Power MOSFET

Absolute maximum ratings

(T_c=25°C)

Characteristic	Symbol	Rating	Unit
Drain-source voltage	V _{DSS}	650	V
Gate-source voltage	V _{GSS}	±30	V
Drain current (DC)*	I _D	(T _c =25°C)	12
		(T _c =100°C)	9.0
Drain current (Pulsed)*	I _{DM}	48	A
Drain power dissipation	P _D	51	W
Avalanche current (Single) ②	I _{AS}	12	A
Single pulsed avalanche energy ②	E _{AS}	700	mJ
Avalanche current (Repetitive) ①	I _{AR}	12	A
Repetitive avalanche energy ①	E _{AR}	11.6	mJ
Junction temperature	T _J	150	°C
Storage temperature range	T _{stg}	-55~150	

* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max	Unit
Thermal resistance	R _{th(J-C)}	-	2.44	°C/W
	R _{th(J-a)}	-	62.5	



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Electrical Characteristics

(Tc=25°C)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV _{DSS}	I _D =250μA, V _{GS} =0	650	-	-	V
Gate threshold voltage	V _{GS(th)}	I _D =250μA, V _{DS} = V _{GS}	2.0	-	4.0	V
Drain-source cut-off current	I _{DSS}	V _{DS} =650V, V _{GS} =0V	-	-	1	μA
Gate leakage current	I _{GSS}	V _{DS} =0V, V _{GS} =±30V	-	-	±100	nA
Drain-source on-resistance ④	R _{DS(ON)}	V _{GS} =10V, I _D =6.0A	-	0.58	0.65	Ω
Forward transfer conductance ④	g _{fs}	V _{DS} =10V, I _D =6.0A	-	10	-	S
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V f=1MHz	-	2100	2950	pF
Output capacitance	C _{oss}		-	168	200	
Reverse transfer capacitance	C _{rss}		-	18	22	
Turn-on delay time	t _{d(on)}	V _{DD} =300V, I _D =12A R _G =25Ω	-	30	-	ns
Rise time	t _r		-	85	-	
Turn-off delay time	t _{d(off)}		-	140	-	
Fall time	t _f		-	90	-	
Total gate charge	Q _g	V _{DS} =400V, V _{GS} =10V I _D =12A	-	42	-	nC
Gate-source charge	Q _{gs}		-	6.0	-	
Gate-drain charge	Q _{gd}		-	16	-	

Source-Drain Diode Ratings and Characteristics

(Tc=25°C)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Source current (DC)	I _S	Integral reverse diode in the MOSFET	-	-	12	A
Source current (Pulsed) ①	I _{SM}		-	-	48	
Forward voltage ④	V _{SD}	V _{GS} =0V, I _S =12A	-	-	1.4	V
Reverse recovery time	t _{rr}	I _S =12A, V _{GS} =0, dI _S /dt=100A/ us	-	500	-	ns
Reverse recovery charge	Q _{rr}		-	4.3	-	uC

Note :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② L=10mH, I_{AS}=12A, V_{DD}=50V, R_G=25Ω , Starting T = 25 °C
- ③ Pulse Test : Pulse Width < 300us, Duty cycle≤ 2%
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 I_D - V_{DS}

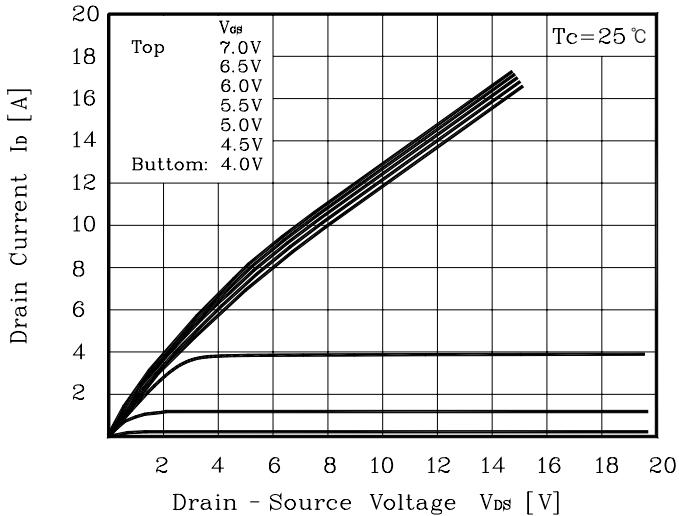


Fig. 2 I_D - V_{GS}

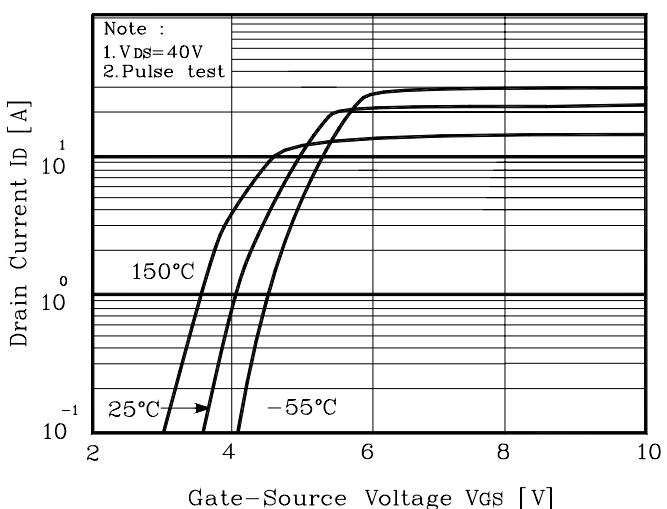


Fig. 3 $R_{DS(on)}$ - I_D

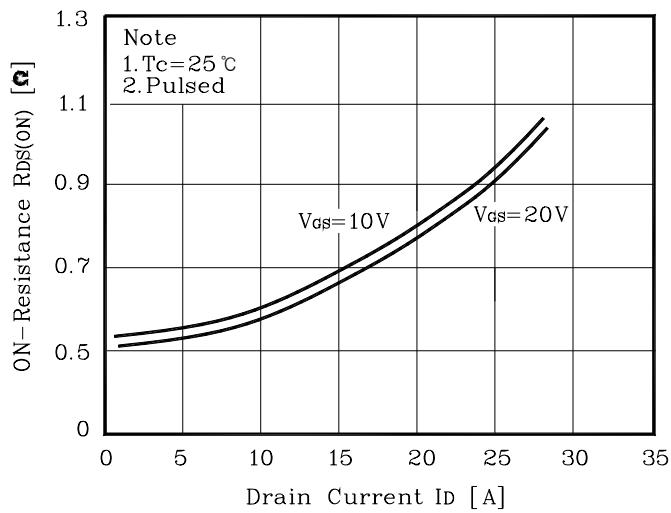


Fig. 4 I_S - V_{SD}

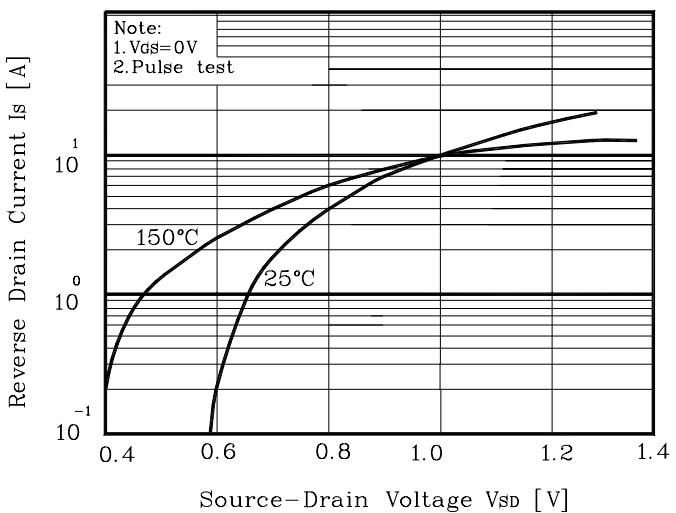


Fig. 5 Capacitance - V_{DS}

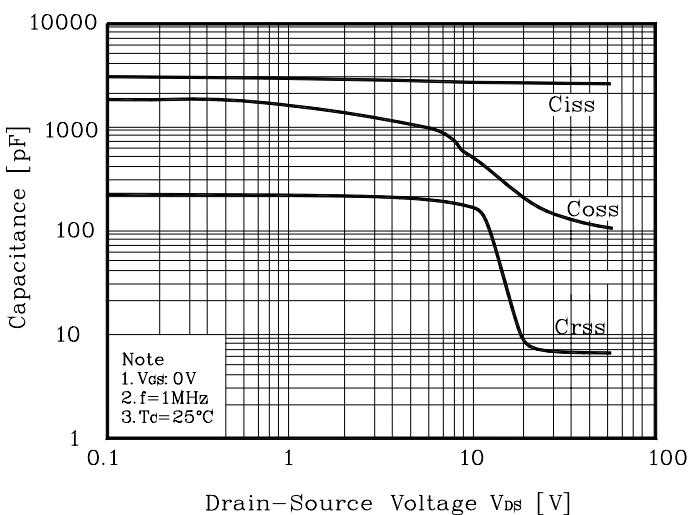
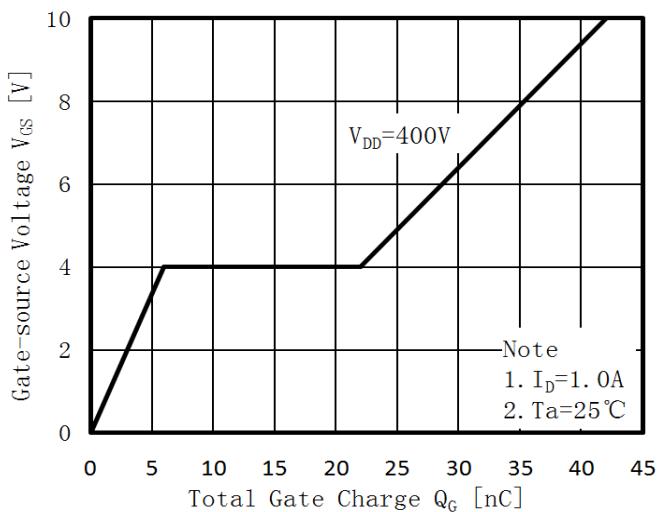


Fig. 6 V_{GS} - Q_G



Electrical Characteristic Curves

Fig. 7 V_{DSS} - T_J

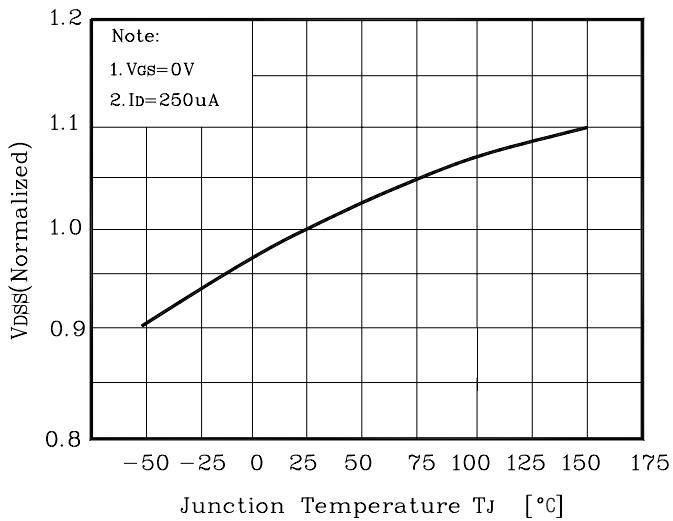


Fig.8 $R_{DS(on)}$ - T_J

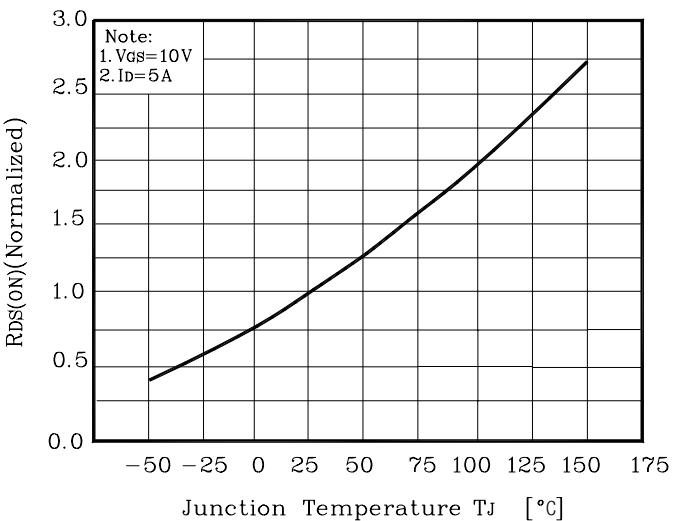


Fig. 9 I_D - T_C

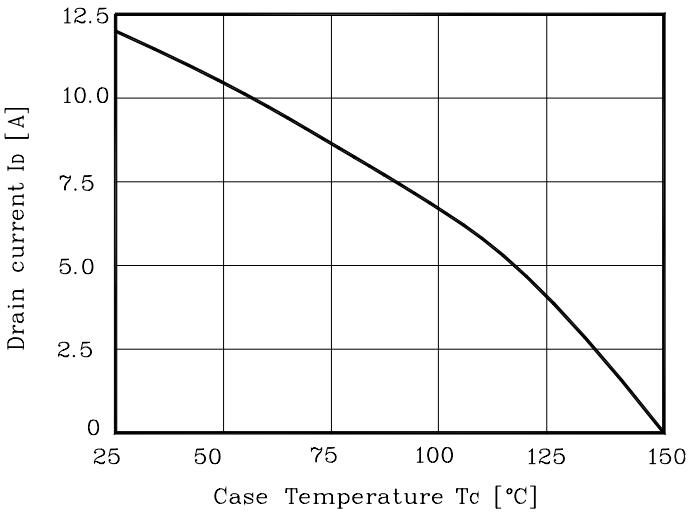


Fig. 10 Safe Operating Area

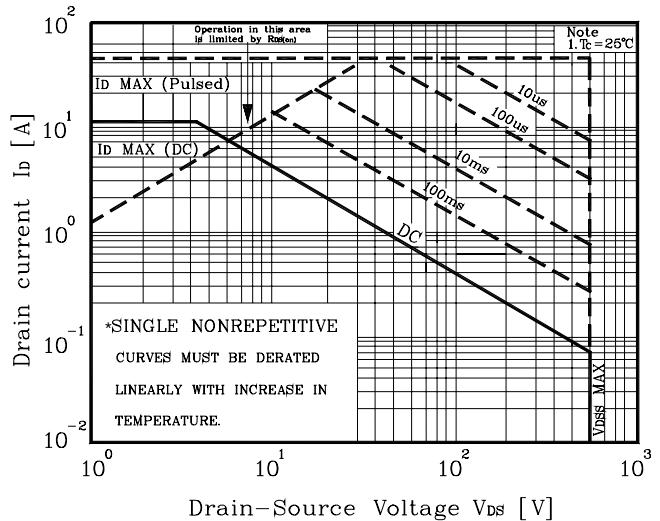


Fig. 10 Gate Charge Test Circuit & Waveform

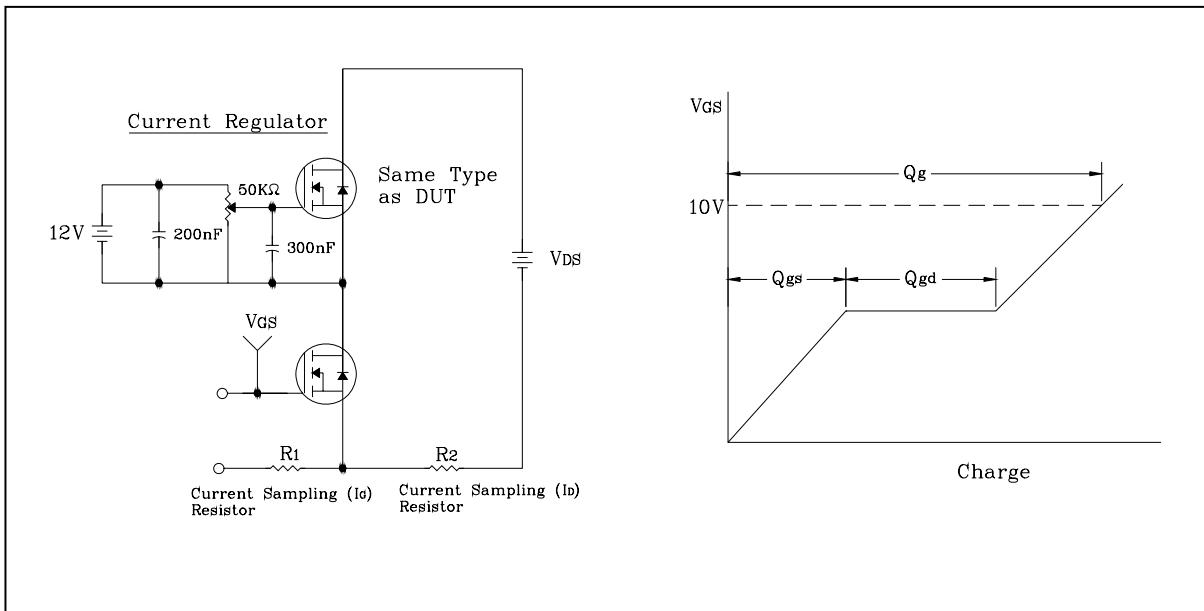


Fig. 11 Resistive Switching Test Circuit & Waveform

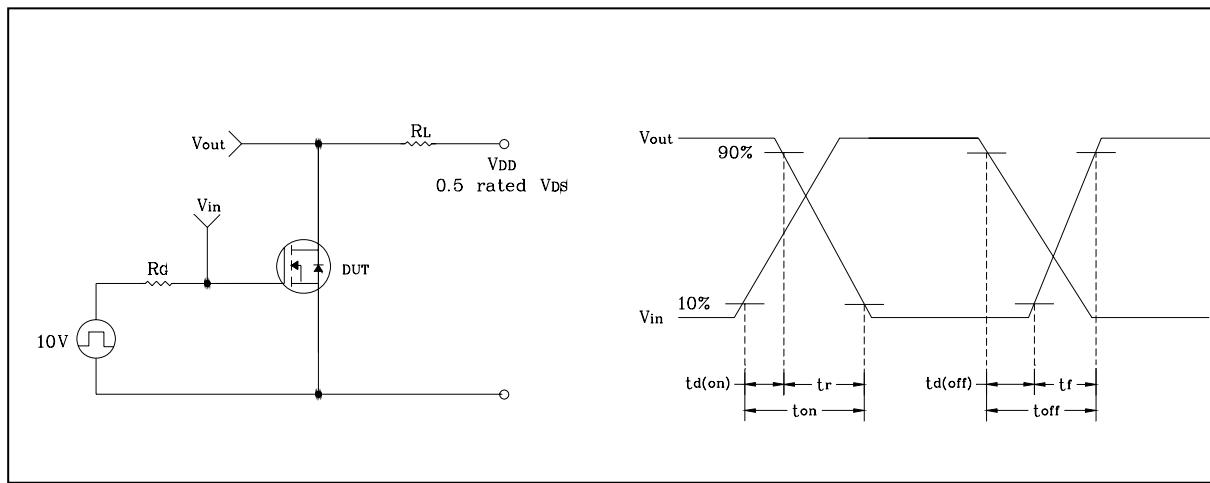


Fig. 12 E_{AS} Test Circuit & Waveform

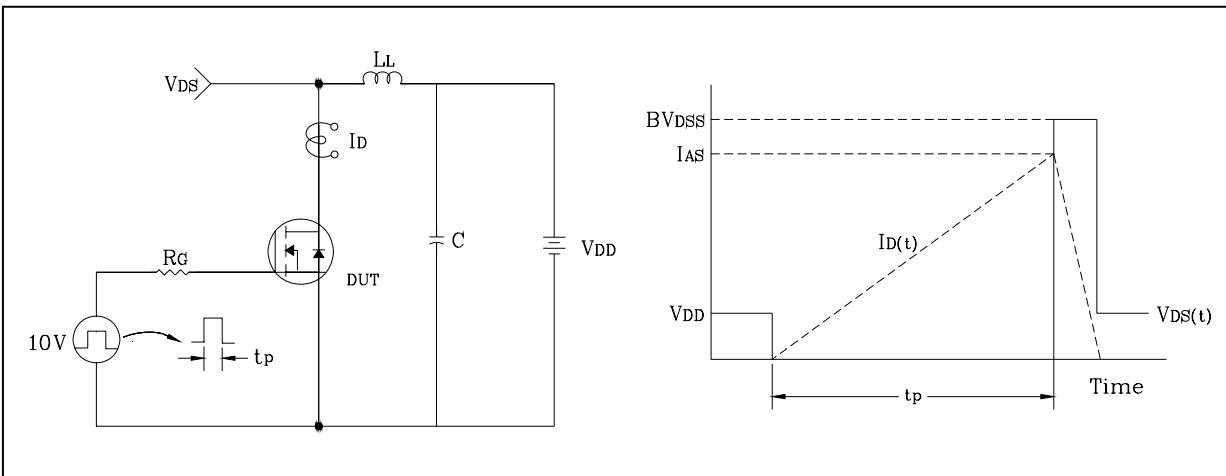
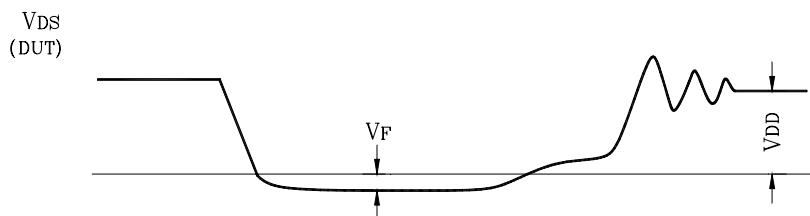
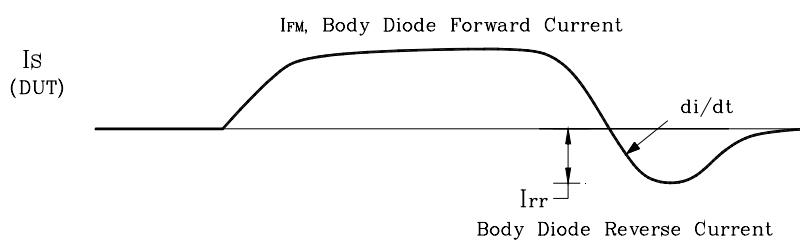
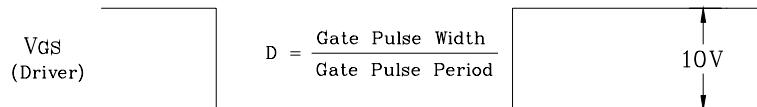
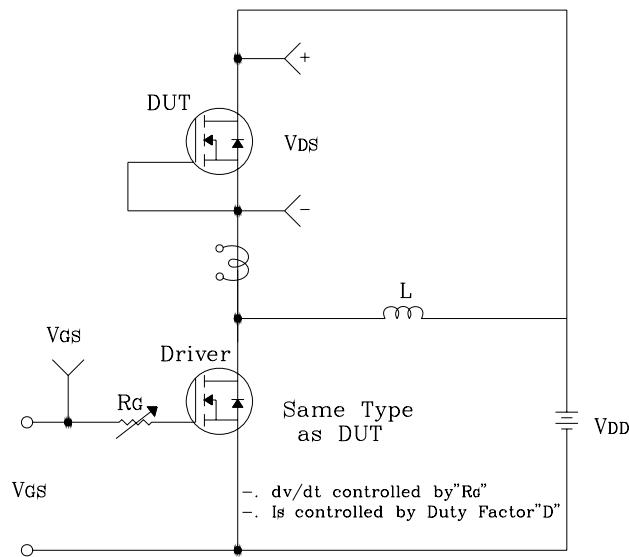


Fig. 13 Diode Reverse Recovery Time Test Circuit & Waveform



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